

Search Notes

Application/Control No.

10/674,633

Examiner

Blake E. Betz

Applicant(s)/Patent under
Reexamination

WORTHINGTON, JOHN W.

Art Unit

2672

SEARCHED

Class	Subclass	Date	Examiner
345	647 648 649	6/6/2005	BB
	660 672	6/6/2005	BB
	619	6/9/2005	BB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
warp and time same (perimeter or size) same (change or edit or resize or expand or contract) same mesh	6/8/2005	BB
(warp\$3 or deform\$4) same time same (perimeter or shape or size or area) same (change or modify or alter or increase or decre	6/9/2005	BB
EAST search	6/9/2005	BB